

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

IN RE APPLICATION OF: Yohichiroh WATANABE, et al.

SERIAL NO: 10/670,320

GAU: 1756

FILED: September 26, 2003

EXAMINER: J. L. DOTE

RCE Filed: August 31, 2006

FOR: TONER, DEVELOPER INCLUDING THE TONER, AND METHOD FOR FIXING TONER IMAGE

INFORMATION DISCLOSURE STATEMENT UNDER 37 CFR 1.97

COMMISSIONER FOR PATENTS
ALEXANDRIA, VIRGINIA 22313

SIR:

Applicant(s) wish to disclose the following information.

REFERENCES

- The applicant(s) wish to make of record the references cited in the three attached Japanese Office Actions and listed on the attached form PTO-1449. Copies of the listed references are attached, where required, as are either statements of relevancy or any readily available English translations of pertinent portions of any non-English language references. The three Japanese Office Action submitted herewith are being filed in the interest of full disclosure and are not Statements of Relevancy.
- Online credit card payment is being made in the amount required under 37 CFR §1.17(p).

RELATED CASES

- ☐ Attached is a list of applicant's pending application(s), published application(s) or issued patent(s) which may be related to the present application. In accordance with the waiver of 37 CFR 1.98 dated September 21, 2004, copies of the cited pending applications are not provided. Cited published and/or issued patents, if any, are listed on the attached PTO form 1449.
- ☐ Online credit card payment is being made in the amount required under 37 CFR §1.17(p).

CERTIFICATION

- ☐ Each item of information contained in this information disclosure statement was first cited in any communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of this statement.
- ☐ No item of information contained in this information disclosure statement was cited in a communication from a foreign patent office in a counterpart foreign application or, to the knowledge of the undersigned, having made reasonable inquiry, was known to any individual designated in 37 CFR §1.56(c) more than three months prior to the filing of this statement.

DEPOSIT ACCOUNT

- Please charge any additional fees for the papers being filed herewith and for which no check or credit card payment is enclosed herewith, or credit any overpayment to deposit account number 15-0030.

Respectfully submitted,

OBLON, SPIVAK, McCLELLAND,
MAIER & NEUSTADT, P.C.
Norman F. Oblon


J. Derek Mason

Registration No. 35,270

James H. Knebel
Registration No. 22,630

Customer Number

22850

Tel. (703) 413-3000
Fax. (703) 413-2220
(OSMMN 05/03)

Form PTO 1449 (Modified)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY DOCKET NO. 242938US0	SERIAL NO. 10/670,320			
LIST OF REFERENCES CITED BY APPLICANT		APPLICANT Yohichiroh WATANABE, et al.				
		FILING DATE: September 26, 2003				
		RCE FILED: August 31, 2006				
		GROUP 1756				
FOREIGN PATENT DOCUMENTS						
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO	
	AA	JP 2002-284881	10/03/2002	JAPAN (with English Abstract)		X
	AB	JP 2001-166538	06/22/2001	JAPAN (with English Abstract)		X
	AC	JP 7-92727	04/07/1995	JAPAN (with English Abstract)		X
	AD	JP 11-338183	12/10/1999	JAPAN (with English Abstract)		X
	AE	JP 2002-351143	12/04/2002	JAPAN (with English Abstract)		X
	AF	JP 2000-292982	10/20/2000	JAPAN (with English Abstract)		X
	AG	JP 2000-181136	06/30/2000	JAPAN (with English Abstract)		X
	AH	JP 10-221887	08/21/1998	JAPAN (with English Abstract)		X
	AI	JP 2002-251084	09/06/2002	JAPAN (with English Abstract)		X
	AJ	JP 9-114283	05/02/1997	JAPAN (with English Abstract)		X
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	AW	JP 5-127415	05/25/1993	JAPAN (with English Abstract)		X
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	AZ	JP 2001-13767	01/19/2001	JAPAN (with English Abstract)		X
					<input checked="" type="checkbox"/> Additional References sheet(s) attached	
Examiner					Date Considered	
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION		
					YES	NO	
	BA	JP 11-65172	03/05/1999	JAPAN (with English Abstract)		X	
	BB	JP 5-281782	10/29/1993	JAPAN (with English Abstract)		X	
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	BH	JP 9-230626	09/05/1997	JAPAN (with English Abstract)		X	
	BI	JP 2002-287400	10/03/2002	JAPAN (with English Abstract)		X	
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